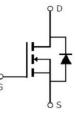


## Main Product Characteristics:

V <sub>DSS</sub>	100V	
R <sub>DS</sub> (on)	3.9m (typ.)	
I <sub>D</sub>	100A	





TO-263 (D2PAK)

Schematic Diagram

#### **Features and Benefits:**

Advanced MOSFET process technology Special designed for PWM, load switching and general purpose applications Ultra low on-resistance with low gate charge Fast switching and reverse body recovery 150 operating temperature



#### **Description:**

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

#### **Absolute Max Rating:**

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	100	٨
I <sub>DM</sub>	Pulsed Drain Current	400	A
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	128	W
V <sub>DS</sub>	Drain-Source Voltage	100	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to +150	°C



Thermal Rooric

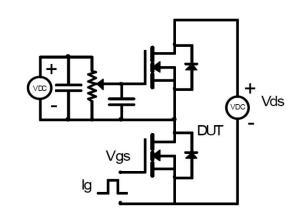


## **Test Circuits and Waveforms**

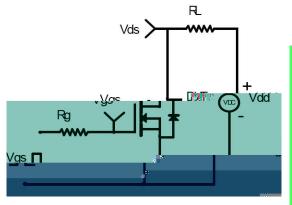
#### EAS Test Circuit:



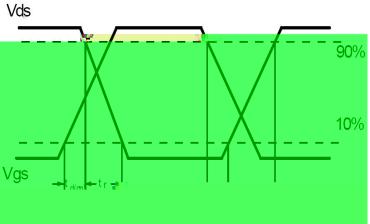
Gate Charge Test Circuit:



Switching Time Test Circuit:



Switching Waveforms:



#### Notes:

Calculated continuous current based on maximum allowable junction temperature.

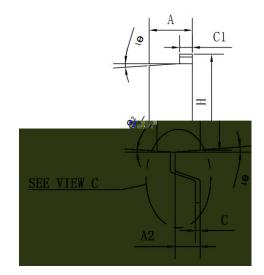
Repetitive rating; pulse width limited by max. junction temperature.

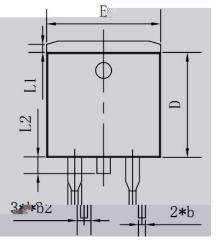
The power dissipation  $P_D$  is based on max. junction temperature, using junction-to-case thermal resistance.

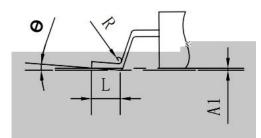


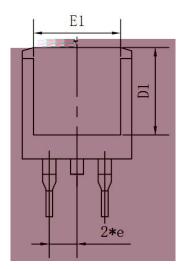
## **Mechanical Data**

TO-263 Package Outline (Unit:mm) Option 1



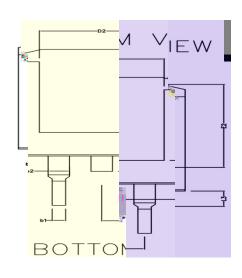


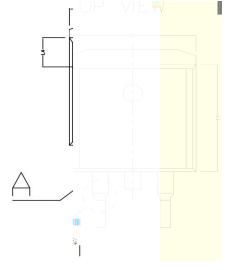


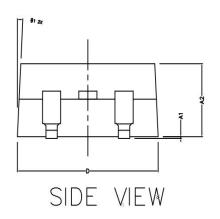


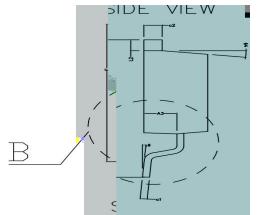
SYMBO	OL MIN	NOM	MAX
A	<mark>4. 3</mark> 5	4. 47	4.60
A1	0. 09	0.10	0.11
A2	2 30	2.40	2. 50
Ь	0.70		1,00
Ь2	1. 25	1.36	1. 38
С	<mark>0.</mark> 45	0.50	0. 55
Êl	1, 29	1.30	1.31
D	<mark>9.</mark> 10	<mark>9</mark> . 20	<mark>9.</mark> 30
D1	7.90	8.00	8.10
E	9, 85	10.00	10.20
E1	7.90	8.00	8.10
Π	15. <mark>30</mark>	15.50	15.70
Ê		2. 51	-
L	2. 34	<u>∠</u> .∰⊣	112. <mark>74</mark>
LI	1. 00	1. 10	t. <mark>20</mark>
L.2	1, 30	1.40	1.50
R	0. 24	0. 25	0.26
θ	0.*	4 °	8*
01	4	7°	l <mark>0</mark> ª
<b>e</b> 2	0*	3*	6°

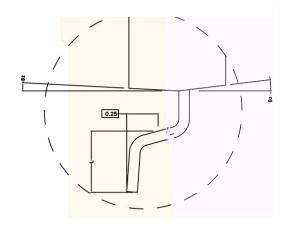




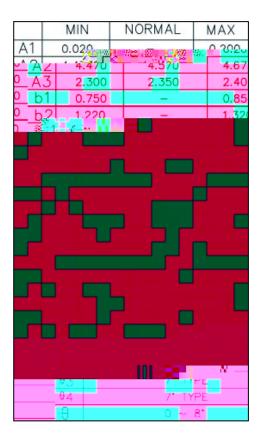














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